

**Search Notes**

Application/Control No.

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Examiner

Sy D. Luu

Applicant(s)/Patent under  
Reexamination

SEKIGUCHI ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	781,792, 806,807	5/29/2007	SL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT US-PGPUB EPO JPO DERWENT	5/29/2007	SL
Text Searches: 715/781,790-797,803,804,806,807	5/29/2007	SL